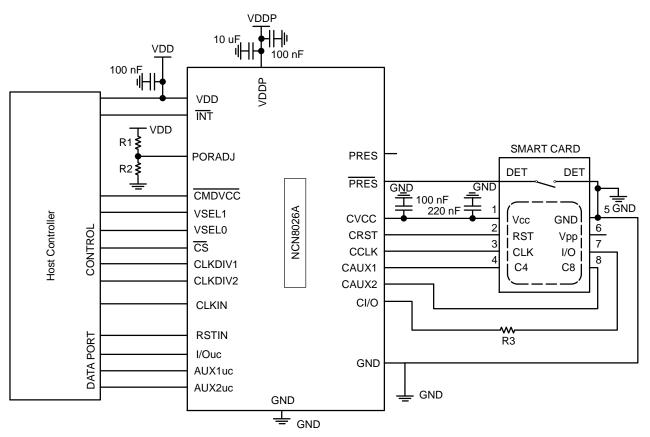
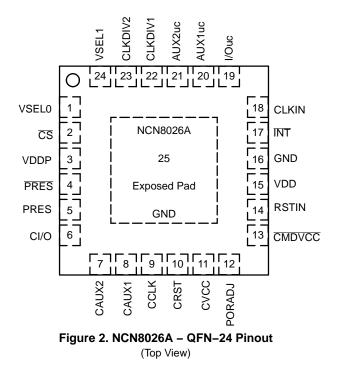
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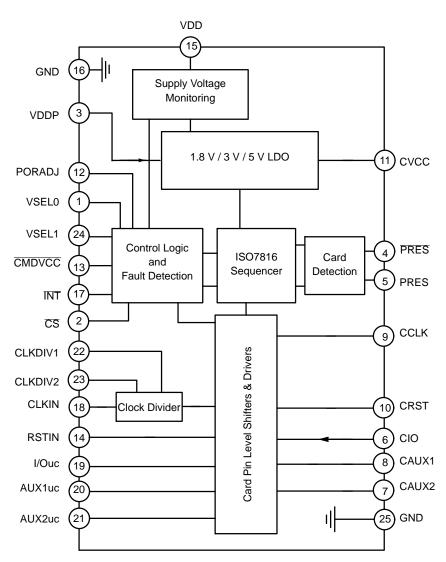


Figure 3. NCN8026A Block Diagram (QFN-24 Pin Numbering)

PIN FUNCTION AND DESCRIPTION

Pin (QFN24)	Name	Туре	Description
6	CI/O	Input/ Output	This pin handles the connection to the serial I/O (C7) of the card connector. A bi–directional level translator adapts the serial I/O signal between the card and the micro controller. A 11 k Ω (typical) pull up resistor to CVCC provides a High impedance state for the smart card I/O link.
7	CAUX2	Input/ Output	This pin handles the connection to the chip card's serial auxiliary AUX2 I/O pin (C8). A bi–directional level translator adapts the serial I/O signal between the card and the micro controller. A 11 k Ω (typical) pull up resistor to CVCC provides a High impedance state for the smart card C8 pin.
8	CAUX1	Input/ Output	This pin handles the connection to the chip card's serial auxiliary AUX1 I/O pin (C4). A bi–directional level translator adapts the serial I/O signal between the card and the micro controller. A 11 k Ω (typical) pull up resistor to CVCC provides a High impedance state for the smart card C4 pin.
9	CCLK	Output	This pin is connected to the CLOCK card connector's pin (Chip card's pin C3). The Clock signal comes from the CLKIN input through clock dividers and level shifter.
10	CRST	Output	This pin is connected to the chip card's RESET pin (C2) through the card connector. A level translator adapts the external Reset (RSTIN) signal to the smart card.
11	CVCC	Power Output	This pin is connected to the smart card power supply pin (C1). An internal low dropout regulator is programmable using the pins VSEL0 and VSEL1 to supply either 5 V or 3 V or 1.8 V output voltage. An external distributed ceramic capacitor ranging from 80 nF to 1.2 μ F recommended must be connected across CVCC and CGND. This set of capacitor (if distributed) must be low ESR (< 100 m Ω).
12	PORADJ	Input	Power-on reset threshold adjustment input pin for changing the reset threshold (V _{DD} UVLO threshold) thanks to an external resistor power divider. Needs to be connected to ground when unused.
13	CMDVCC	Input	Command V _{CC} pin. Activation sequence Enable/Disable pin (active Low). The activation sequence is enabled by toggling \overline{CMDVCC} High to Low and when a card is present. When \overline{CMDVCC} = High, the CVCC output is pulled low and the internal LDO is disabled unless the device has been latched by the \overline{CS} pin.
14	RSTIN	Input	This Reset input connected to the host and referred to VDD (microcontroller side), is connected to the

ATTRIBUTES

Characteristics	Values		
ESD protection Human Body Model (HBM) (Note 1) Card Pins (card interface pins 4–11) All Other Pins Machine Model (MM) Card Pins (card interface pins 4–11) All Other Pins	8 kV 2 kV 400 V 150 V		
Moisture sensitivity (Note 2) QFN-24	Level 1		
Flammability Rating Oxygen Index: 28 to 34	UL 94 V-0 @ 0.125 in		
Meets or exceeds JEDEC Spec EIA/JESD78 IC Latch-up Test			

1. Human Body Model (HBM), R = 1500 $\Omega,$ C = 100 pF.

2. For additional information, see Application Note AND8003/D.

MAXIMUM RATINGS (Note 3)

Rating	Symbol	Value	Unit
Regulator Power Supply Voltage	V _{DDP}	–0.3 V _{DDP} 5.5	V
Power Supply from Microcontroller Side	V _{DD}	–0.3 V _{DD} 5.5	V
External Card Power Supply	CVCC	-0.3 CVCC 5.5	V
Digital Input Pins	V _{in}	–0.3 V _{in} V _{DD}	V
Digital Output Pins (I/Ouc, AUX1uc, AUX2uc, INT)	V _{out}	–0.3 V _{out} V _{DD}	V
Smart card Output Pins	V _{out}	-0.3 V _{out} CVCC	V
Thermal Resistance Junction-to-Air QFN-2	4 R _{θJA}	90	C/W
Operating Ambient Temperature Range	T _A	-40 to +85	С
Operating Junction Temperature Range	TJ	-40 to +125	С
Maximum Junction Temperature	T _{Jmax}	+125	С
Storage Temperature Range	T _{stg}	-65 to + 150	С

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 3. Maximum electrical ratings are defined as those values beyond which damage to the device may occur at $T_A = +25$ C.

POWER SUPPLY SECTION (V_{DD} = 3.3 V; V_{DDP} = 5 V; T_{amb} = 25 C; F_{CLKIN} = 5 MHz)

Symbol

Rating

Min

HOST INTERFACE SECTION

SMART CARD INTERFACE SECTION CI/O, CAUX1, CAUX2, CCLK, CRST, PRES, PRES (V_{DD} = 3.3 V; V_{DDP} = 5 V; T_{amb} = 25

SMART CARD INTERFACE SECTION CI/O, CAUX1, CAUX2, CCLK, CRST, PRES, \overline{PRES} (V_{DD} = 3.3 V; V_{DDP} = 5 V; T_{amb} = 25 C; F_{CLKIN} = 5 MHz)

Symbol	Rating	Min	Тур	Мах	Unit

 $|I_{\rm H}|$

Finally the Reset level shifter is enabled (typically 2 μ s after clock channel) (t4)

The clock can also be applied to the card using a **RSTIN mode** allowing controlling the clock starting by setting RSTIN Low (Figure 4). Before running the activation sequence, that is before setting Low <u>CMDVCC</u> RSTIN is set High. The following sequence is applied:

The Smart Card Interface is enable by setting CMDVCC LOW (RSTIN is High).

Between t2 (Figure 4) and t5 = 240 μ s, RSTIN is reset to LOW and CCLK will start precisely at this moment allowing a precise count of clock cycles before toggling CRST Low to High for ATR (Answer To Reset) request.

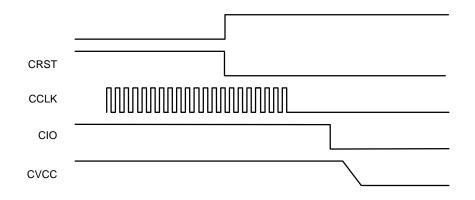
CRST remains LOW until 240 μ s; after t5 = 240 μ s CRST is enabled and is the copy of RSTIN which has no more control on the clock. If controlling the clock with RSTIN is not necessary (**Normal Mode**), then $\overline{\text{CMDVCC}}$ can be set LOW with RSTIN LOW. In that case, CLK will start minimum 2 µs after the transition on I/O (Figure 5), and to obtain an ATR, CRST can be set High by RSTIN also about 2 µs after the clock channel activation (T_{act}).

The internal activation sequence activates the different channels according to a specific hardware built in sequencing internally defined but at the end the actual activation

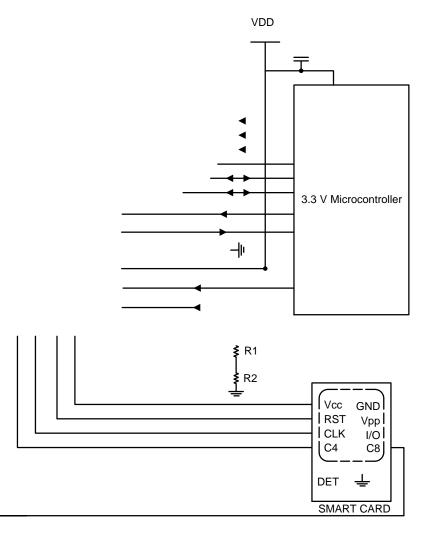
SMART CARD POWER-DOWN

When the communication session is completed the NCN8026A runs a deactivation sequence by setting High CMDVCC. The below power down sequence is executed:

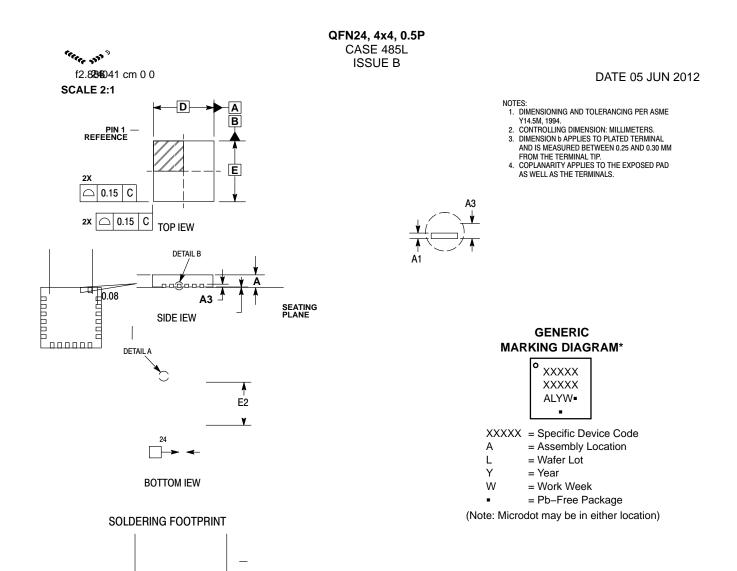
CRST is forced to Low CCLK is set Low 12 µs after CRST. CI/O, CAUX1 and CAUX2 are pulled Low Finally CVCC supply can be shut off.



APPLICATION SCHEMATIC







2.90

DIMENSIONS: MILLIMETERS

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